

Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
S36	34886	(ohmic near contact)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/08 16:50
S37	340660	diffusing or diffused or diffuse	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/08 16:51
S38	64549	a-si or (amorphous near silicon)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/08 16:51
S39	534	(remove or removing or removed) near8 (impurity or impurities) near8 channel	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/08 16:54
S40	7	S36 same S39	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/08 16:57
S41	43	S36 and S39	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/08 16:57
S42	25	S41 and ((@ad<"20010219") or (@rlad<"20010219"))	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/08 17:04
S43	11744	S37 near8 (impurity or impurities or phosphorous or P) near8 (a-si or amorphous or semiconductor)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/08 17:03

S44	3337	((438/149) or (438/151) or (438/156) or (438/482)).CCLS.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/11/08 17:04
S45	135	S43 and S44	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/08 17:04
S46	91	S45 and ((@ad<"20010219") or (@rlad<"20010219"))	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/08 17:10
S47	16	S46 and S36	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/08 17:11
S48	4	("4892837" "5700714" "5981317" "6251715").PN.	US-PGPUB; USPAT; USOCR	OR	ON	2005/11/08 17:12